**Power LDMOS transistor** 

Rev. 2 — 3 November 2010

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

250 W LDMOS power transistor for base station applications at frequencies from 1450 MHz to 1550 MHz.

#### Table 1. Typical performance

Typical RF performance at  $T_{case} = 25 \ ^{\circ}C$  in a class-AB production test circuit.

Mode of operation	f	$V_{\text{DS}}$	P <sub>L(AV)</sub>	G <sub>p</sub>	ηр	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
2C-WCDMA	1476 to 1511	28	60	18.5	33.0	-32 <mark>[1]</mark>

 Test signal: 3GPP; test model 1; 64 DPCH; PAR = 7.5 dB at 0.01 % probability on CCDF per carrier. Carrier spacing 5 MHz.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

#### 1.2 Features and benefits

- Typical 2C-WCDMA performance at frequencies of 1476 MHz and 1511 MHz, a supply voltage of 28 V and an I<sub>Dq</sub> of 1410 mA:
  - Average output power = 60 W
  - Power gain = 18.5 dB
  - Efficiency = 33.0 %
  - ♦ ACPR = -32 dBc
- Easy power control
- Integrated ESD protection
- Enhanced ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (1450 MHz to 1550 MHz)
- Internally matched for ease of use
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC
- Integrated current sense



#### **1.3 Applications**

RF power amplifiers for GSM, GSM EDGE, CDMA and W-CDMA and multi carrier applications in the 1450 MHz to 1550 MHz frequency range

### 2. Pinning information

Pin	Description		Simplified outline	Graphic symbol
1	drain1			
2	drain2			
3	gate1			
4	gate2			
5	source	<u>[1]</u>		
6, 7	sense drain			٣
8, 9	sense gate			2 sym12

#### 3. Ordering information

Table 3. Ordering information			
Type number Package			
	Name	Description	Version
BLF6G15L-250PBRN	-	flanged LDMOST ceramic package; 2 mounting holes; 8 leads	SOT1110A

### 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage		-	65	V
V <sub>GS</sub>	gate-source voltage		-0.5	+11	V
I <sub>D</sub>	drain current		-	64	А
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

## 5. Thermal characteristics

Table 5.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-case)</sub>	thermal resistance from junction to case	$T_{case} = 80 \ ^{\circ}C; P_{L} = 60 \ W \ (CW)$	0.29	K/W

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#### 6. Characteristics

<b>Table 6.</b> $T_j = 25 \ ^{\circ}C$	Characteristics per section; unless otherwise spec	cified				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS}$ = 0 V; $I_D$ = 1.8 mA	65	75	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$V_{DS}$ = 10 V; $I_{D}$ = 180 mA	1.4	1.9	2.4	V
I <sub>Dq</sub>	quiescent drain current	sense transistor: $I_{DS}$ = 20.1 mA; $V_{DS}$ = 12 V main transistor: $V_{DS}$ = 28 V	1.31	1.41	1.51	A
I <sub>DSS</sub>	drain leakage current	$V_{GS}$ = 0 V; $V_{DS}$ = 28 V	-	-	2.8	μA
I <sub>DSX</sub>	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{\mathrm{GS}} = V_{\mathrm{GS}(\mathrm{th})} + 3.75 \ V; \\ V_{\mathrm{DS}} = 10 \ V \end{array}$	25.3	29	-	A
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = 11 V; $V_{DS}$ = 0 V	-	-	280	nA
<b>g</b> fs	forward transconductance	$V_{DS} = 10 \text{ V}; I_{D} = 9 \text{ A}$	8.1	11.3	-	S
R <sub>DS(on)</sub>	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 V;$ I <sub>D</sub> = 6.3 A	0.03	0.1	0.16	Ω

### 7. Application information

#### Table 7. RF performance

Mode of operation: 2-carrier W-CDMA; PAR 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 DPCH;  $f_1 = 1473.4$  MHz;  $f_2 = 1478.4$  MHz;  $f_3 = 1508.4$  MHz;  $f_4 = 1513.4$  MHz; RF performance at  $V_{DS} = 28$  V;  $I_{Dq} = 1410$  mA;  $T_{case} = 25$  °C; unless otherwise specified in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
P <sub>L(AV)</sub>	average output power		-	60	-	W
G <sub>p</sub>	power gain	$P_{L(AV)} = 60 \text{ W}$	16.5	18.5	-	dB
RL <sub>in</sub>	input return loss	$P_{L(AV)} = 60 \text{ W}$	8	12	-	dB
$\eta_D$	drain efficiency	$P_{L(AV)} = 60 \text{ W}$	30	33	-	%
ACPR	adjacent channel power ratio	$P_{L(AV)} = 60 \text{ W}$	-	-32	-27	dBc

#### Table 8. PAR performance

Mode of operation; 1-carrier W-CDMA; PAR 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 DPCH;  $f_1 = 1510.9$  MHz; RF performance at  $V_{DS} = 28$  V;  $I_{Dq} = 1410$  mA;  $T_{case} = 25$  °C; unless otherwise specified in a class-AB production test circuit.

cuco		•				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
PARO	output peak-to-average ratio	P <sub>L(AV)</sub> = 120 W at 0.01 % probability on CCDF	3.4	4.2	-	dB

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1.93

1.97

Table 9.Phase binningOff state $S_{11}$ measurement; $V_{DS}$ =	$= 28 V; V_{GS} = 0 V$	
Marking code	Input Resonance Frequency (C	GHz)
	Min	Мах
1	1.85	1.89

1.89

1.93

Table 10.	Gain binning	

2

3

Mode of operation: 2-carrier W-CDMA; PAR 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 DPCH;  $f_1 = 1473.4$  MHz,  $f_2 = 1478.4$  MHz;  $P_{L(AV)} = 60$  W;  $V_{DS} = 28$  V;  $I_{Dq} = 1410 \ mA$ 

Marking code	Gain at a center frequency of 1475.9 MHz in dB		
	Min	Мах	
BT	17.0	17.5	
BU	17.5	18.0	
BW	18.0	18.5	
BX	18.5	19.0	

#### 7.1 Ruggedness in class-AB operation

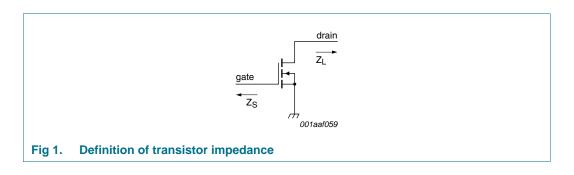
The BLF6G15L-250PBRN is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:  $V_{DS} = 28 V$ ; I<sub>Dg</sub> = 1410 mA; P<sub>L</sub> = 200 W; f = 1475 MHz.

#### 7.2 Impedance information

#### Table 11. Typical impedance per section

$I_{Dq} = 950 \text{ mA}$ ; main transistor $V_{DS} = 28 \text{ V}$		
f	Z <sub>S</sub> <sup>[1]</sup>	ZL <sup>[1]</sup>
(MHz)	(Ω)	(Ω)
1480	1.1 – j2.8	2.3 – j3.2
1510	1.3 – j2.8	2.1 – j2.8

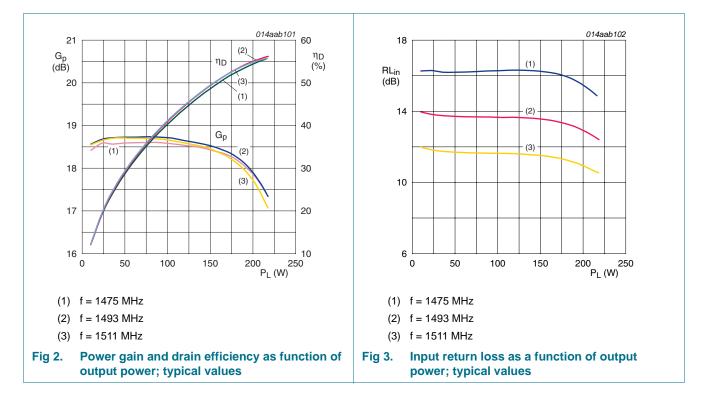
[1]  $Z_S$  and  $Z_L$  defined in Figure 1.



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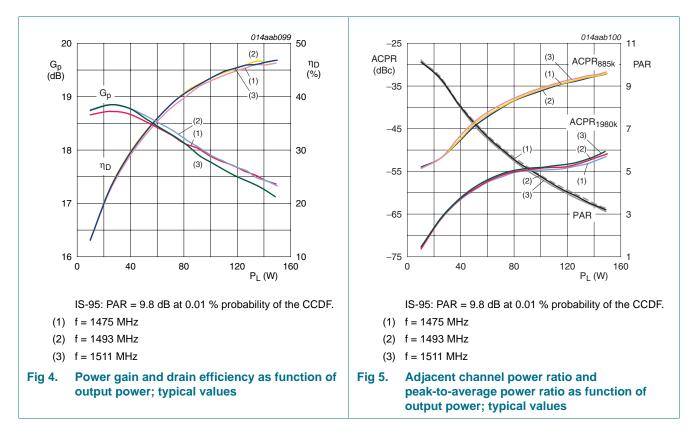
7.3 Graphs

7.3.1 CW

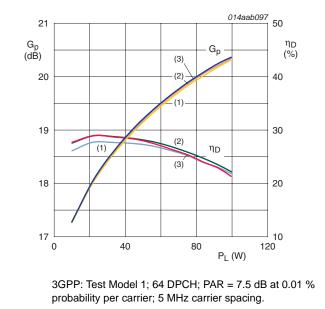


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7.3.2 IS-95

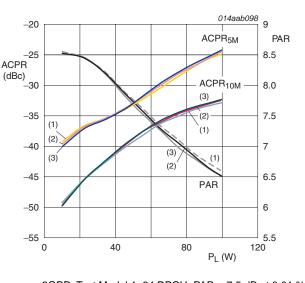


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#### 7.3.3 2C-WCDMA (5 MHz spacing)

- (1) f = 1475 MHz
- (2) f = 1493 MHz
- (3) f = 1511 MHz
- Fig 6. Power gain and drain efficiency as function of output power; typical values



3GPP: Test Model 1; 64 DPCH; PAR = 7.5 dB at 0.01 % probability per carrier; 5 MHz carrier spacing.

- (1) f = 1475 MHz
- (2) f = 1493 MHz
- (3) f = 1511 MHz
- Fig 7. Adjacent channel power ratio and peak-to-average power ratio as function of output power; typical values

### 8. Test information

### Table 12. List of components

See Figure 8 for component layout.

Component	Description	Value	Remarks
C1, C2, C3, C4	multi layer ceramic chip capacitor	100 pF	<u>[1]</u>
C5, C6	multi layer ceramic chip capacitor	10 μF	[2]
C7	multi layer ceramic chip capacitor	10 nF	2 on input gate line as shown
C8	multi layer ceramic chip capacitor	100 nF	[2]
C10	multi layer ceramic chip capacitor	2.4 pF	[1]
C11	multi layer ceramic chip capacitor	3.6 pF	[3]
C12	electrolytic capacitor	470 μF; 63 V	
C13, C14, C15, C16	multi layer ceramic chip capacitor	33 pF	[3]
R1	chip resistor	3.9 kΩ	Philips 0603
R2	chip resistor	2.2 kΩ	Philips 0603
R3	chip resistor	10 Ω	Philips 0603
R4	chip resistor	0 Ω	Philips 0603

[1] American Technical Ceramics type 800B or capacitor of same quality.

[2] TDK or capacitor of same quality.

[3] American Technical Ceramics type 100B or capacitor of same quality.

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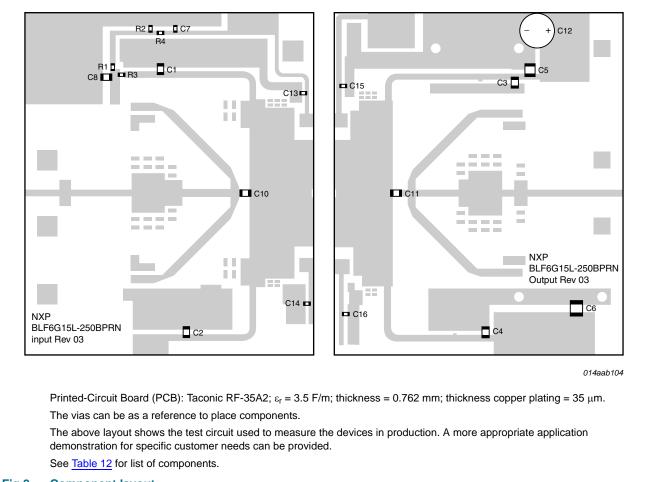
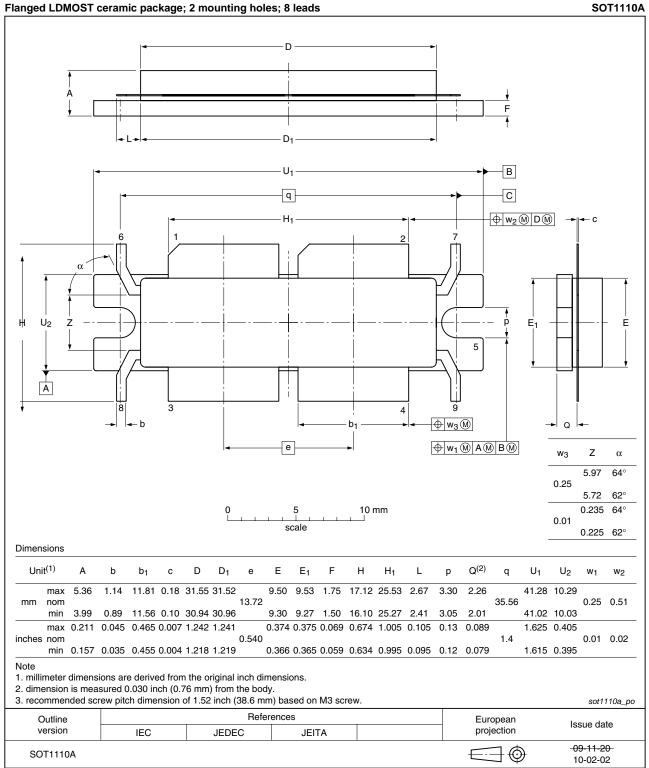


Fig 8. Component layout

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#### **Package outline** 9.



#### Flanged LDMOST ceramic package; 2 mounting holes; 8 leads

Package outline SOT1110A Fig 9.

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## **10. Abbreviations**

Table 13.	Abbreviations
Acronym	Description
CCDF	Complementary Cumulative Distribution Function
CDMA	Code Division Multiple Access
CW	Continuous Wave
EDGE	Enhanced Data rates for GSM Evolution
DPCH	Dedicated Physical CHannel
GSM	Global System for Mobile communications
IS-95	Interim Standard 95
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
VSWR	Voltage Standing-Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

# **11. Revision history**

Table 14. Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF6G15L-250PBRN v.2	20101103	Product data sheet	-	BLF6G15L-250PBRN v.1
BLF6G15L-250PBRN v.1	20100914	Preliminary data sheet	-	-

Product data sheet

### **12. Legal information**

#### 12.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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